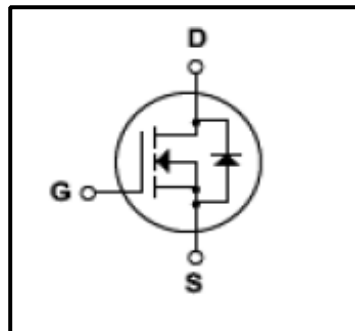


Silicon N-Channel MOSFET

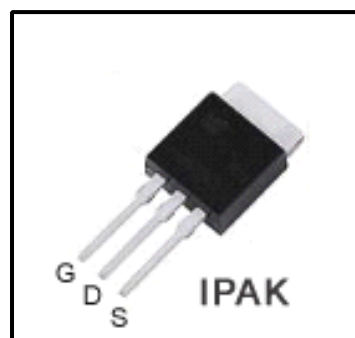
Features

- 4.5A,600V, $R_{DS(on)}$ (Max2.5 Ω)@ $V_{GS}=10V$
- Ultra-low Gate charge(Typical 16nC)
- Fast Switching Capability
- 100%Avalanche Tested
- Maximum Junction Temperature Range(150 $^{\circ}C$)



General Description

This Power MOSFET is produced using Winsemi's advanced planar stripe,VDMOS technology.this latest technology has been especially designed to minimize on-state resistance, have a high rugged avalanche characteristics .This devices is specially well suited for half bridge and full bridge resonant topology line a electronic lamp ballast, high efficiency switched mode power supplies, active power factor correction.



Absolute Maximum Ratings

| Symbol | Parameter | Value | Units |
|----------------|---|----------|----------------|
| V_{DSS} | Drain Source Voltage | 600 | V |
| I_D | Continuous Drain Current(@ $T_c=25^{\circ}C$) | 4.5 | A |
| | Continuous Drain Current(@ $T_c=100^{\circ}C$) | 3.0 | A |
| I_{DM} | Drain Current Pulsed (Note1) | 20 | A |
| V_{GS} | Gate to Source Voltage | ± 30 | V |
| E_{AS} | Single Pulsed Avalanche Energy (Note2) | 300 | mJ |
| E_{AR} | Repetitive Avalanche Energy (Note1) | 12 | mJ |
| dv/dt | Peak Diode Recovery dv /dt (Note3) | 4.5 | V/ns |
| P_D | Total Power Dissipation(@ $T_c=25^{\circ}C$) | 51 | W |
| | Derating Factor above 25 $^{\circ}C$ | 0.39 | W/ $^{\circ}C$ |
| T_J, T_{stg} | Junction and Storage Temperature | -55~150 | $^{\circ}C$ |
| T_L | Channel Temperature | 300 | $^{\circ}C$ |

Thermal Characteristics

| Symbol | Parameter | Value | | | Units |
|-----------|---|-------|-----|-----|---------------|
| | | Min | Typ | Max | |
| R_{QJC} | Thermal Resistance , Junction -to -Case | - | - | 2.5 | $^{\circ}C/W$ |
| R_{QJA} | Thermal Resistance , Junction-to -Ambient | - | - | 83 | $^{\circ}C/W$ |

Electrical Characteristics(Tc=25°C)

| Characteristics | Symbol | Test Condition | Min | Type | Max | Unit | |
|--|----------------------|---|--|------|------|------|----|
| Gate leakage current | I _{GSS} | V _{GS} =±30V,V _{DS} =0V | - | - | ±100 | nA | |
| Gate-source breakdown voltage | V _{(BR)GSS} | I _G =±10 μA,V _{DS} =0V | ±30 | - | - | V | |
| Drain Cut -off current | I _{DSS} | V _{DS} =600V,V _{GS} =0V | - | - | 10 | μA | |
| | | V _{DS} =480V,Tc=125°C | - | - | 100 | μA | |
| Drain -source breakdown voltage | V _{(BR)DSS} | I _D =250 μA,V _{GS} =0V | 600 | - | - | V | |
| Gate threshold voltage | V _{GS(th)} | V _{DS} =10V,I _D =250 μA | 2 | - | 4 | V | |
| Drain -source ON resistance | R _{DS(ON)} | V _{GS} =10V,I _D =2.2A | - | 2.1 | 2.5 | Ω | |
| Forward Transconductance | g _{fs} | V _{DS} =50V,I _D =2.2A | - | 4.0 | - | S | |
| Input capacitance | C _{iss} | V _{DS} =25V, | - | 520 | 670 | pF | |
| Reverse transfer capacitance | C _{rss} | V _{GS} =0V, | - | 9 | 10.5 | | |
| Output capacitance | C _{oss} | f=1MHz | - | 70 | 90 | | |
| Switching time | Rise time | tr | V _{DD} =300V, I _D =4.4A R _G =25Ω (Note4,5) | - | 13 | 35 | ns |
| | Turn-on time | ton | | - | 45 | 100 | |
| | Fall time | tf | | - | 25 | 60 | |
| | Turn-off time | toff | | - | 35 | 80 | |
| Total gate charge(gate-source plus gate-drain) | Q _g | V _{DD} =480V, V _{GS} =10V, | - | 16 | 20 | nC | |
| Gate-source charge | Q _{gs} | I _D =4.4A | - | 3.4 | - | | |
| Gate-drain("miller") Charge | Q _{gd} | (Note,5) | - | 7 | - | | |

Source-Drain Ratings and Characteristics(Ta=25°C)

| Characteristics | Symbol | Test Condition | Min | Type | Max | Unit |
|----------------------------------|------------------|--|-----|------|------|------|
| Continuous drain reverse current | I _{DR} | - | - | - | 4.5 | A |
| Pulse drain reverse current | I _{DRP} | - | - | - | 17.6 | A |
| Forward voltage(diode) | V _{DSF} | I _{DR} =4.4A,V _{GS} =0V | - | - | 1.4 | V |
| Reverse recovery time | trr | I _{DR} =4.4A,V _{GS} =0V, | 290 | - | - | ns |
| Reverse recovery charge | Q _{rr} | dI _{DR} /dt =100 A /μs | 2 | - | - | μC |

Note 1.Repeativity rating :pulse width limited by junction temperature

2.L=18.5mH I_{AS}=4.4A,V_{DD}=50V,R_G=0Ω,Starting T_J=25°C

3.I_{SD}≤4.4A,di/dt≤200A/us,V_{DD}<BV_{DSS},STARTING T_J=25°C

4.Pulse Test:Pulse Width≤300us,Duty Cycle≤2%

5. Essentially independent of operating temperature.

This transistor is an electrostatic sensitive device

Please handle with caution

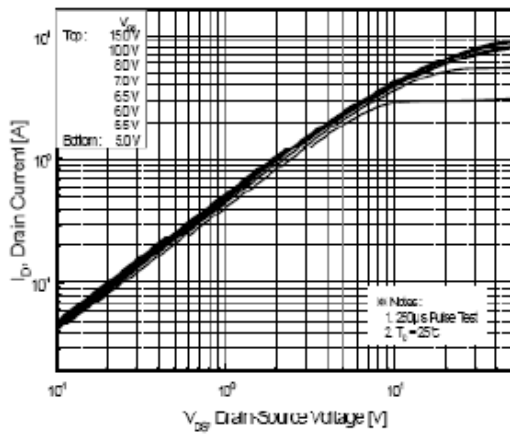


Fig.1 On-State characteristics

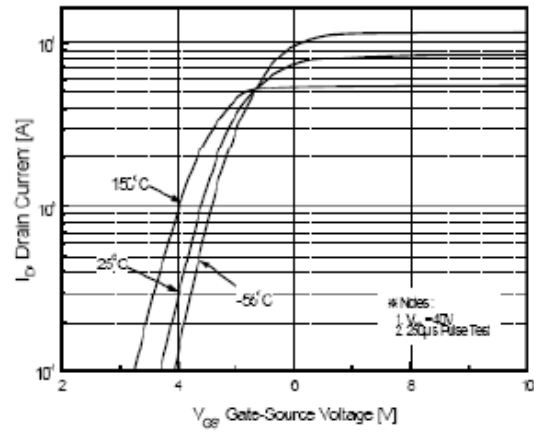


Fig.2 Transfer Current characteristics

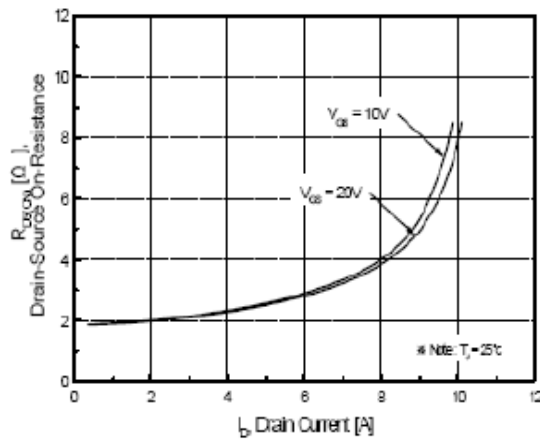


Fig.3 On-Resistance Variation vs Drain Current

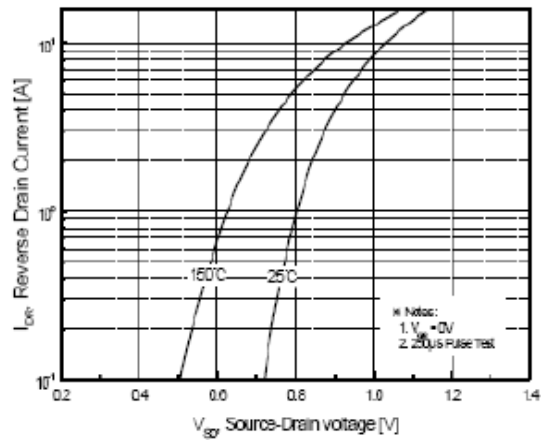


Fig.4 Body Diode Forward Voltage Variation with Source Current and Temperature

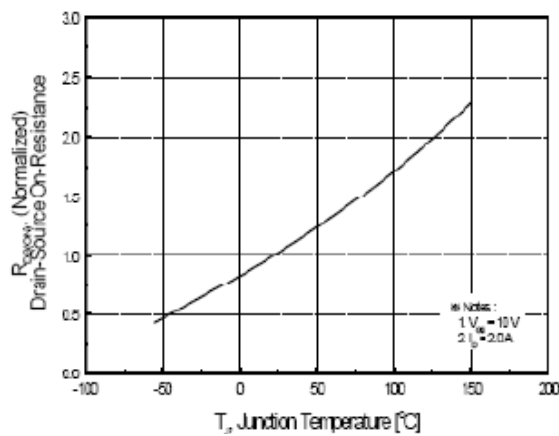


Fig.5 On-Resistance Variation vs Junction Temperature

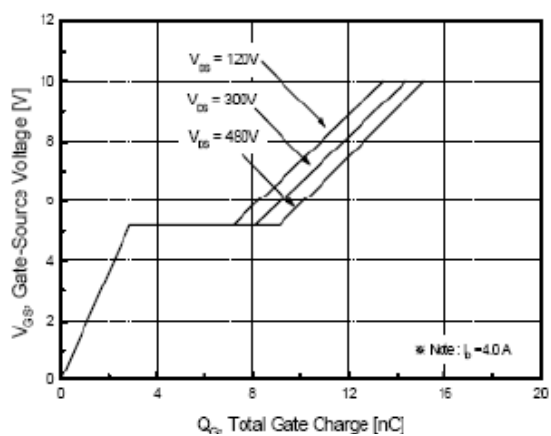


Fig.6 Gate Charge Characteristics

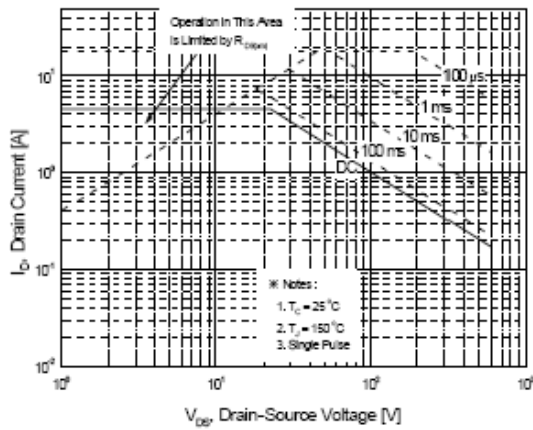


Fig.7 Maximum Safe Operation Area

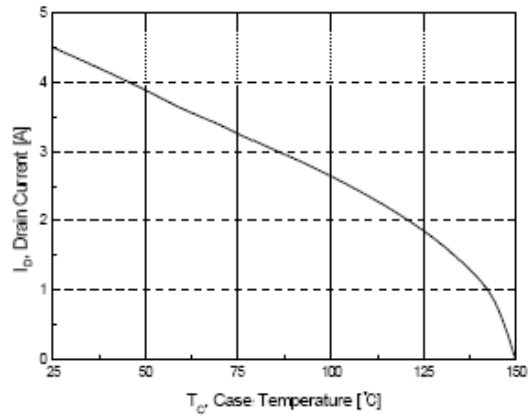


Fig.8 Maximum Drain Current vs Case Temperature

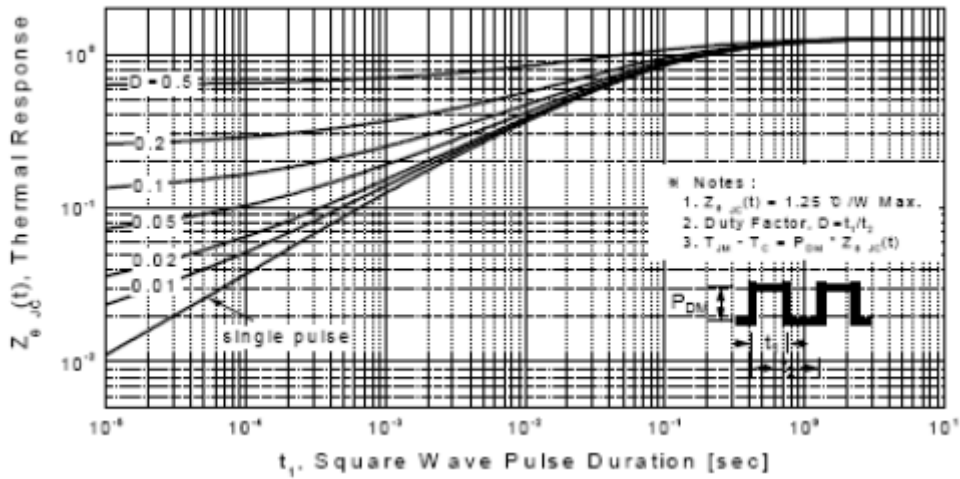


Fig.9 Transient Thermal Response Curve

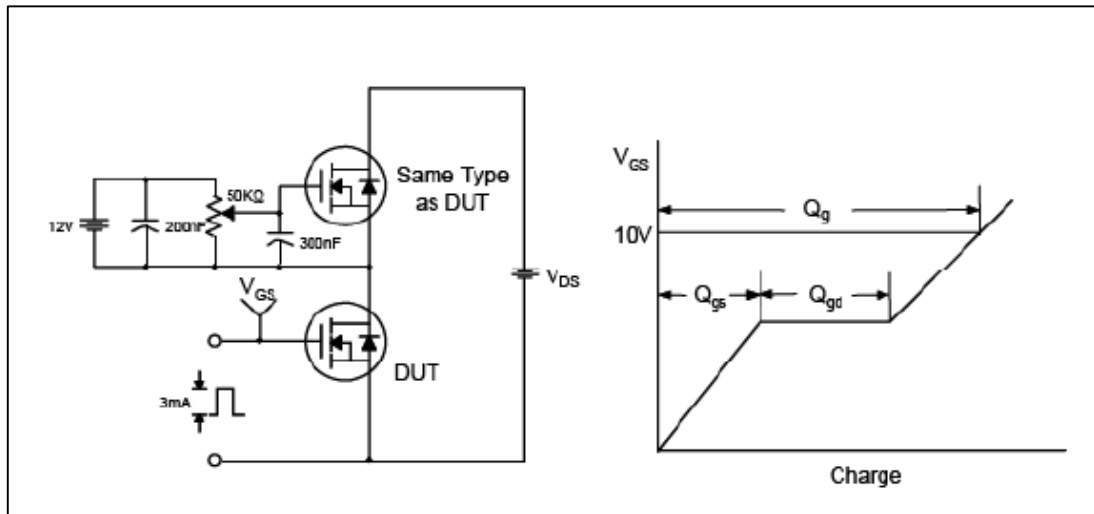


Fig.10 Gate Test Circuit & Waveform

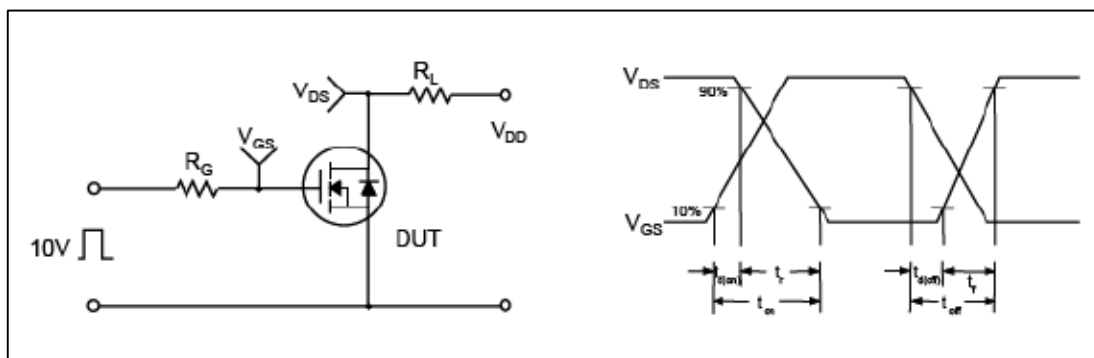


Fig.11 Resistive Switching Test Circuit & Waveform

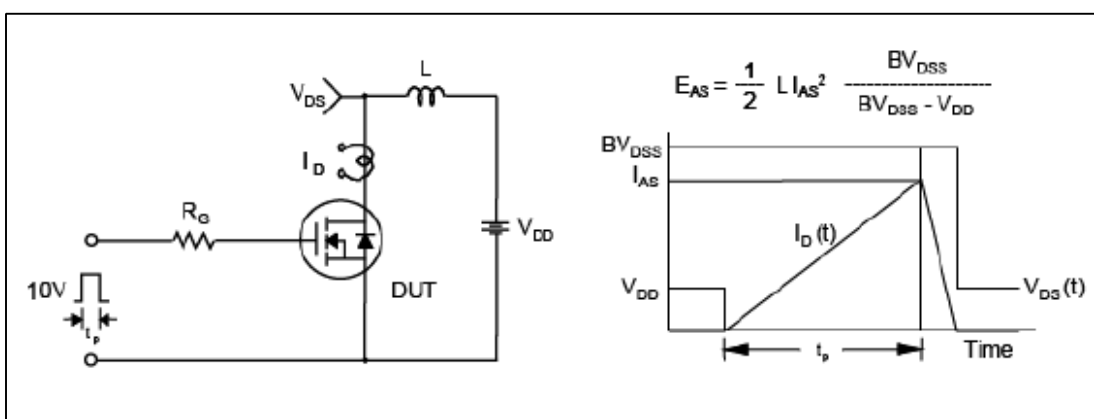


Fig.12 Unclamped Inductive Switching Test Circuit & Waveform

IPAK Package Dimension

